

FCC RF TEST REPORT

ISSUED BY
Shenzhen BALUN Technology Co., Ltd.



FOR LTE Digital Mobile Handset

ISSUED TO
ZTE Corporation

ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District,
Shenzhen, Guangdong, P. R. China



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Date Jun. 16. 2017

Approved by: Liao Jianming
Liao Jianming
(Technical Director)

Date Jun. 16. 2017

Report No.: BL-SZ1760126-601

EUT Name: LTE Digital Mobile Handset

Model Name: BGH Joy A20

Brand Name: ZTE

Test Standard: 47 CFR Part 15 Subpart C

FCC ID: SRQ-A210

Test conclusion: Pass

Test Date: Jun. 09, 2017 ~ Jun. 16, 2017

Date of Issue: Jun. 16, 2017

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Revision History

<u>Version</u>	<u>Issue Date</u>	<u>Revisions Content</u>
<u>Rev. 01</u>	<u>Jun. 16, 2017</u>	<u>Initial Issue</u>

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1 ADMINISTRATIVE DATA (GENERAL INFORMATION)

1.1 Identification of the Testing Laboratory

Company Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Identification of the Responsible Testing Location

Test Location	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1st FL, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory has been listed by Industry Canada to perform electromagnetic emission measurements. The recognition numbers of test site are 11524A-1. The laboratory has been listed by US Federal Communications Commission to perform electromagnetic emission measurements. The recognition numbers of test site are 832625. The laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L6791.
Description	All measurement facilities used to collect the measurement data are located at Block B, FL 1, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China 518055

1.3 Laboratory Condition

Ambient Temperature	20 to 25°C
Ambient Relative Humidity	45% - 55%
Ambient Pressure	100 kPa - 102 kPa

1.4 Announce

- (1) The test report reference to the report template version v5.7.
- (2) The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
- (3) The test report is invalid if there is any evidence and/or falsification.
- (4) The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
- (5) This document may not be altered or revised in any way unless done so by BALUN and all revisions are duly noted in the revisions section.
- (6) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	ZTE Corporation
Address	ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, P.R.China

2.2 Manufacturer Information

Manufacturer	ZTE Corporation
Address	ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, P.R.China

2.3 Factory Information

Factory	N/A
Address	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Type	LTE Digital Mobile Handset
Model Name Under Test	BGH Joy A20
Series Model Name	BGH Joy A20, ZTE Blade A210
Description of Model name differentiation	The equipment model BGH Joy A20 and ZTE Blade A210 are the LTE Digital Mobile Handset model, the electrical parameters and internal structure of circuit are same, only the model name is different.
Hardware Version	BGH_JOY_A20_V1AMB_B
Software Version	BGH_Joy_A20_ARMovistar_1.01
Dimensions (Approx.)	134.8*67.5*10.15 mm
Weight (Approx.)	150 g
Network and Wireless connectivity	2G Network GSM/GPRS/EDGE 850/1900 MHz 3G Network WCDMA/HSDPA/HSUPA Band 2/4/5 4G Network FDD LTE Band 4/7 Bluetooth 3.0, Bluetooth 4.0 Low Energy (BLE), 802.11b, 802.11g and 802.11n (HT20/40), GPS, GLONASS, FM

2.5 Ancillary Equipment

Ancillary Equipment 1	Battery	
	Brand Name	ZTE
	Model No.	Li3822T43P3h675053
	Serial No.	N/A
	Capacitance	2200 mAh
	Rated Voltage	3.8 V
	Extreme Voltage	4.35 V
Ancillary Equipment 2	Adapter	
	Brand Name	ZTE
	Model No.	STC-A22O50I1000USBA-A
	Rated Input	100-240 V~, 300 mA, 50/60 Hz
	Rated Output	5 V=, 1 A
Ancillary Equipment 3	USB Cable	
	Length(Approx.)	0.7 m
Ancillary Equipment 4	Earphone	
	Length(Approx.)	1.2 m

2.6 Technical Information

The requirement for the following technical information of the EUT was tested in this report:

Modulation Technology	FHSS
Modulation Type	GFSK, $\pi/4$ -DQPSK, 8-DPSK
Product Type	☒ Mobile ☐ Portable ☐ Fix Location
Transfer Rate	DH5: 1 Mbps 2DH5: 2 Mbps 3DH5: 3 Mbps
Frequency Range	The frequency range used is 2400 MHz to 2483.5 MHz.
Number of channel	79 (at intervals of 1 MHz)
Tested Channel	0 (2402 MHz), 39 (2441 MHz), 78 (2480 MHz)
Antenna Type	PIFA Antenna
Antenna Gain	2.1 dBi (All involve the antenna gain test item, has been included in the final results)
Antenna System(MIMO Smart Antenna)	N/A

All channel was listed on the following table:

Channel number	Freq. (MHz)	Channel number	Freq. (MHz)	Channel number	Freq. (MHz)	Channel number	Freq. (MHz)
0	2402	21	2423	42	2444	63	2465
1	2403	22	2424	43	2445	64	2466
2	2404	23	2425	44	2446	65	2467
3	2405	24	2426	45	2447	66	2468
4	2406	25	2427	46	2448	67	2469
5	2407	26	2428	47	2449	68	2470
6	2408	27	2429	48	2450	69	2471
7	2409	28	2430	49	2451	70	2472
8	2410	29	2431	50	2452	71	2473
9	2411	30	2432	51	2453	72	2474
10	2412	31	2433	52	2454	73	2475
11	2413	32	2434	53	2455	74	2476
12	2414	33	2435	54	2456	75	2477
13	2415	34	2436	55	2457	76	2478
14	2416	35	2437	56	2458	77	2479
15	2417	36	2438	57	2459	78	2480
16	2418	37	2439	58	2460	-	-
17	2419	38	2440	59	2461	-	-
18	2420	39	2441	60	2462	-	-
19	2421	40	2442	61	2463	-	-
20	2422	41	2443	62	2464	-	-

2.7 Additional Instructions

EUT Software Settings:

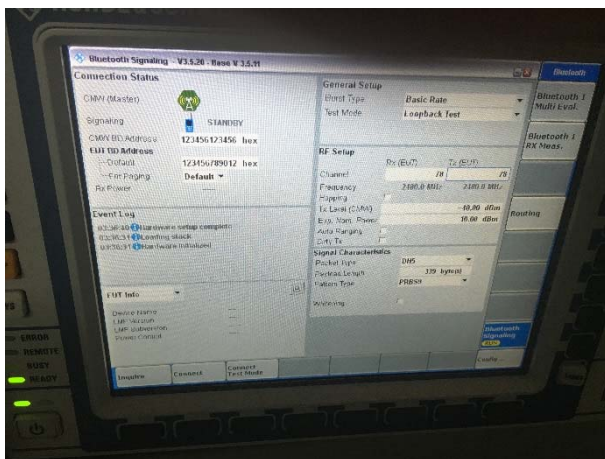
Mode	☒ Bluetooth test mode loop back enabled. EUT is controlled over CBT / CMU.
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During testing, Channel and Power Controlling Software provided by the customer was used to control the operating channel as well as the output power level. The RF output power selection is for the setting of RF output power expected by the customer and is going to be fixed on the firmware of the final end prod

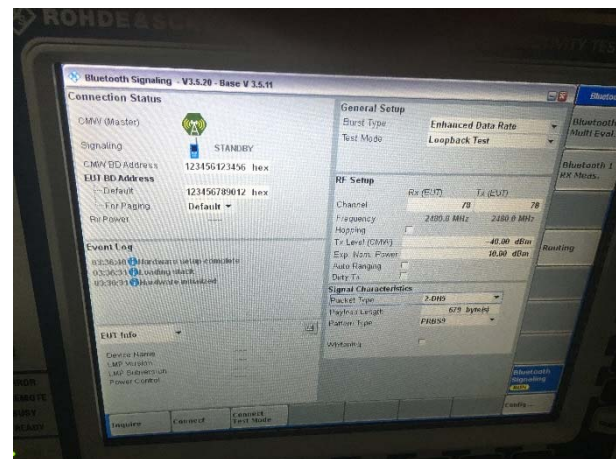
Power level setup in software			
Test Software Version	N/A		
Mode	Channel	Frequency (MHz)	Soft Set
DH5	CH0	2402	TX LEVEL is built-in set parameters and cannot be changed and selected.
	CH39	2441	
	CH78	2480	
2DH5	CH0	2402	
	CH39	2441	
	CH78	2480	
3DH5	CH0	2402	
	CH39	2441	
	CH78	2480	

Run Software:

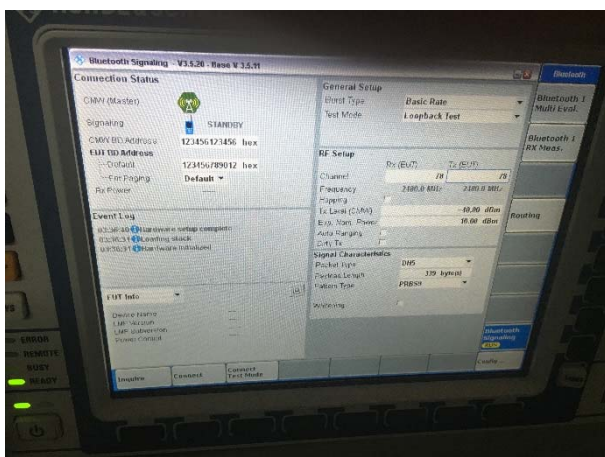
DH5



2DH5



3DH5



3 SUMMARY OF TEST RESULTS

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 15, Subpart C (10-1-15 Edition)	Miscellaneous Wireless Communications Services
2	FCC PUBLIC NOTICE DA 00-705 (Mar. 30, 2000)	Filling and Measurement Guidelines for Frequency Hopping Spread Spectrum Systems
3	ANSI C63.10-2013	American National Standard for Testing Unlicensed Wireless Devices

3.2 Verdict

No.	Description	FCC Part No.	ISED Part No.	Channel	Test Result	Verdict	Remark
1	Antenna Requirement	15.203	RSS-247, 5.4 (6)	N/A	--	Pass	Note ¹
2	Number of Hopping Frequencies	15.247(a)	RSS-247, 5.1 (4)	Hopping Mode	ANNEX A.1	Pass	Note ²
3	Peak Output Power and E.I.R.P	15.247(b)	RSS-247, 5.4 (2)	Low/Middle/High	ANNEX A.2	Pass	--
4	Occupied Bandwidth	15.247(a)	RSS-247, 5.1 (1)	Low/Middle/High	ANNEX A.3	Pass	Note ²
5	Carrier Frequency Separation	15.247(a)	RSS-247, 5.1 (2)	Hopping Mode	ANNEX A.4	Pass	Note ²
6	Time of Occupancy (Dwell time)	15.247(a)	RSS-247, 5.1 (4)	Hopping Mode	ANNEX A.5	Pass	Note ²
7	Conducted Spurious Emission & Authorized-band band-edge	15.247(d)	RSS-247, 5.5	Low/Middle/High	ANNEX A.6	Pass	Note ²
8	Conducted Emission	15.207	RSS-GEN, 8.8	Low/Middle/High	ANNEX A.7	Pass	Note ²
9	Radiated Spurious Emission	15.209 15.247(d)	RSS-247, 5.5	Hopping Mode, Low/Middle/High	ANNEX A.8	Pass	Note ²
10	Band Edge(Restricted-band band-edge)	15.209 15.247(d)	RSS-247, 5.5	Hopping Mode, Low/Middle/High	ANNEX A.9	Pass	Note ²
11	Receiver Spurious Emissions	--	RSS-Gen, 7.1.2	--	--	N/A	Note ³

Note ¹: Please refer to section 5.1

Note ²: Because of the modulation of $\pi/4$ -DQPSK same as 8-DPSK, and the test results are basically the same with them, so we chose 8-DPSK as a typical representative to appear on the report. Another we will show all the modes on the RF output power test item

Note ³: Only radio communication receivers operating in stand-alone mode within the band 30-960 MHz, as well as scanner receivers, are subject to Industry Canada requirements, so this test is not applicable.

Note ⁴: Because of the EUT (Test sample in this report) is based on the test sample (Test report No. is BL-SZ1650193-602, and it issued by Shenzhen BALUN Technology Co., Ltd. on Jun. 12, 2016) to reduce the test band 28, change the Charger and the LTE antenna. The other hardware circuit and software all the same. So just Conducted Emission and Radiated Spurious Emission (30MHz-1GHz) were retested in this report. The other test items please refer to BL-SZ1650193-602 which issued by Shenzhen BALUN Technology Co., Ltd. on Jun. 12, 2016.

4 GENERAL TEST CONFIGURATIONS

4.1 Test Environments

During the measurement, the normal environmental conditions were within the listed ranges:

Relative Humidity	45% - 55%	
Atmospheric Pressure	100 kPa - 102 kPa	
Temperature	NT (Normal Temperature)	+22°C to +25°C
Working Voltage of the EUT	NV (Normal Voltage)	3.8 V

4.2 Test Equipment List

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Spectrum Analyzer	ROHDE&SCHWARZ	FSV-30	103118	2016.07.13	2017.07.12
Switch Unit with OSP-B157	ROHDE&SCHWARZ	OSP120	101270	2016.07.13	2017.07.12
EMI Receiver	KEYSIGHT	N9038A	MY53220118	2016.09.09	2017.09.08
EMI Receiver	ROHDE&SCHWARZ	ESRP	101036	2016.07.05	2017.07.04
LISN	SCHWARZBECK	NSLK 8127	8127-687	2016.07.05	2017.07.04
Bluetooth Tester	ROHDE&SCHWARZ	CBT	101005	2016.07.13	2017.07.12
Power Splitter	KMW	DCPD-LDC	1305003215	--	--
Power Sensor	ROHDE&SCHWARZ	NRP-Z21	103971	2016.07.13	2017.07.12
Attenuator (20 dB)	KMW	ZA-S1-201	110617091	--	--
Attenuator (6 dB)	KMW	ZA-S1-61	1305003189	--	--
DC Power Supply	ROHDE&SCHWARZ	HMP2020	018141664	2016.07.13	2017.07.12
Temperature Chamber	ANGELANTIONI SCIENCE	NTH64-40A	1310	2016.07.13	2017.07.12
Test Antenna-Loop(9 kHz-30 MHz)	SCHWARZBECK	FMZB 1519	1519-037	2015.07.22	2017.07.21
Test Antenna-Bi-Log(30 MHz-3 GHz)	SCHWARZBECK	VULB 9163	9163-624	2015.07.22	2017.07.21
Test Antenna-Horn(1-18 GHz)	SCHWARZBECK	BBHA 9120D	9120D-1148	2015.07.22	2017.07.21
Test Antenna-Horn(15-26.5 GHz)	SCHWARZBECK	BBHA 9170	9170-305	2015.07.22	2017.07.21
Anechoic Chamber	RAINFORD	9m*6m*6m	N/A	2017.02.21	2019.02.20
Anechoic Chamber	EMC Electronic Co., Ltd	20.10*11.60*7.35m	N/A	2016.08.09	2018.08.08
Shielded Enclosure	ChangNing	CN-130701	130703	--	--
Signal Generator	ROHDE&SCHWARZ	SMB100A	177746	2016.07.13	2017.07.12
Power Amplifier	OPHIR RF	5225F	1037	2017.02.17	2018.02.16
Power Amplifier	OPHIR RF	5273F	1016	2017.02.17	2018.02.16

Description	Manufacturer	Model	Serial No.	Cal. Date	Cal. Due
Directional Coupler	Werlantine	C5982-10	109275	N/A	N/A
Directional Coupler	Werlantine	CHP-273E	S00801z-01	N/A	N/A
Feld Strength Meter	Narda	EP601	511WX5112 9	2017.02.23	2018.02.22
Mouth Simulator	B&K	4227	2423931	2016.11.15	2017.11.14
Sound Calibrator	B&K	4231	2430337	2016.11.09	2017.11.08
Sound Level Meter	B&K	NL-20	00844023	2016.11.11	2017.11.10
Ear Simulator	B&K	4185	2409449	2016.11.15	2017.11.14
Ear Simulator	B&K	4195	2418189	2016.11.15	2017.11.14
Audio analyzer	B&K	UPL 16	100129	2016.11.08	2017.11.07

4.3 Measurement Uncertainty

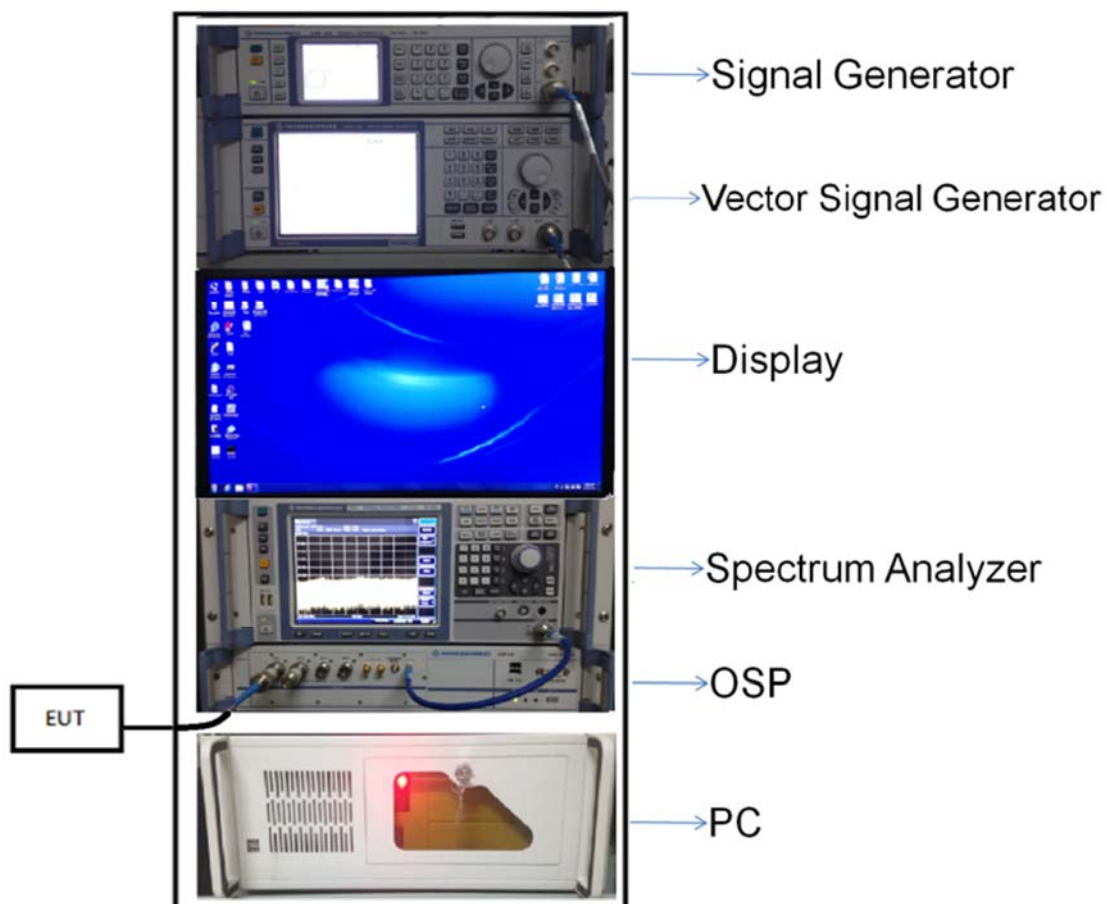
The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2.

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

Measurement	Value
Occupied Channel Bandwidth	$\pm 4\%$
RF output power, conducted	± 1.4 dB
Power Spectral Density, conducted	± 2.5 dB
Unwanted Emissions, conducted	± 2.8 dB
All emissions, radiated	± 5.4 dB
Temperature	$\pm 1^{\circ}\text{C}$
Humidity	$\pm 4\%$

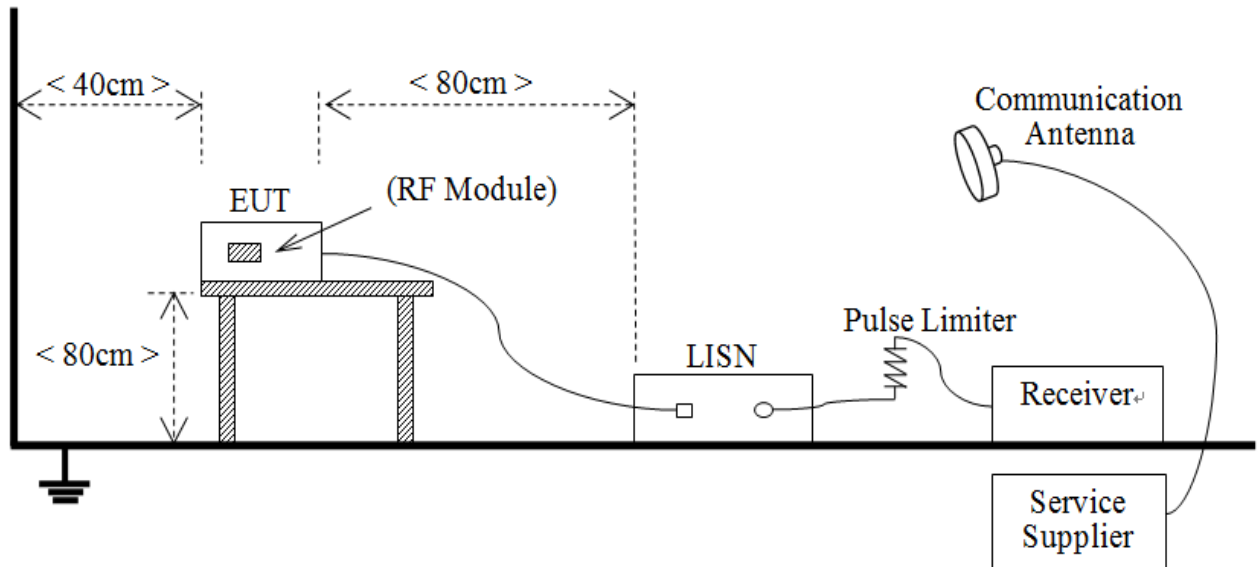
4.4 Description of Test Setup

4.4.1 For Antenna Port Test



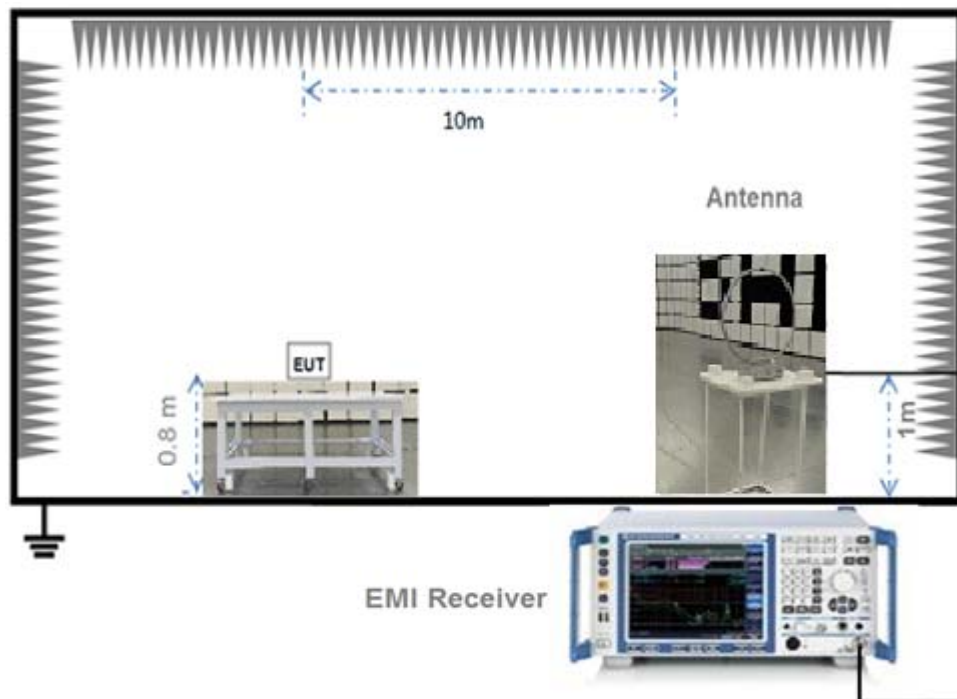
(Diagram 1)

4.4.2 For AC Power Supply Port Test



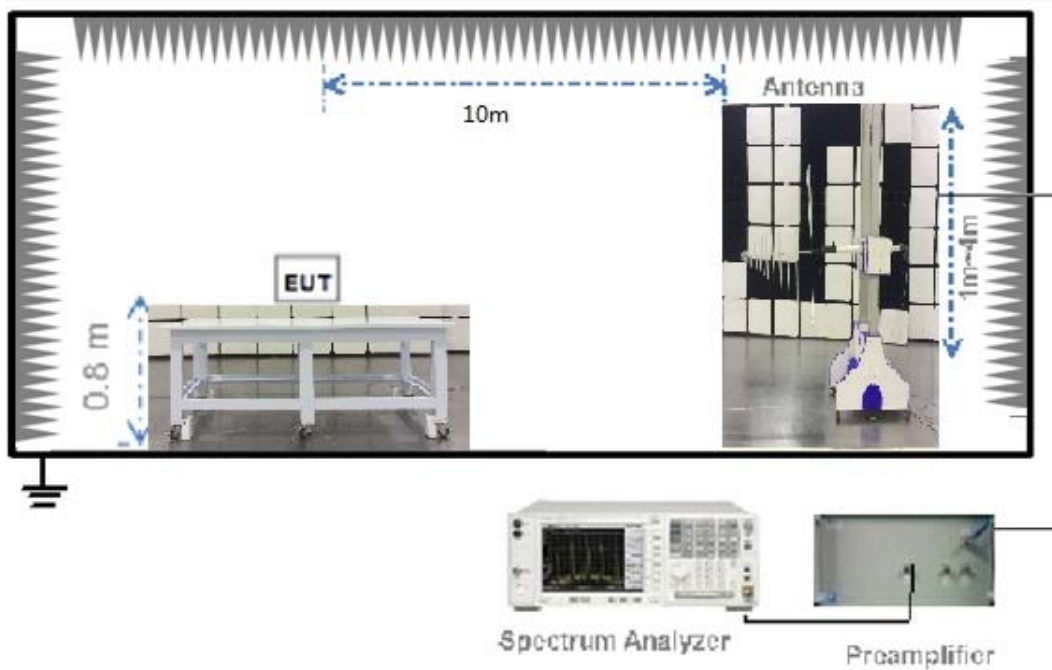
(Diagram 2)

4.4.3 For Radiated Test (Below 30 MHz)



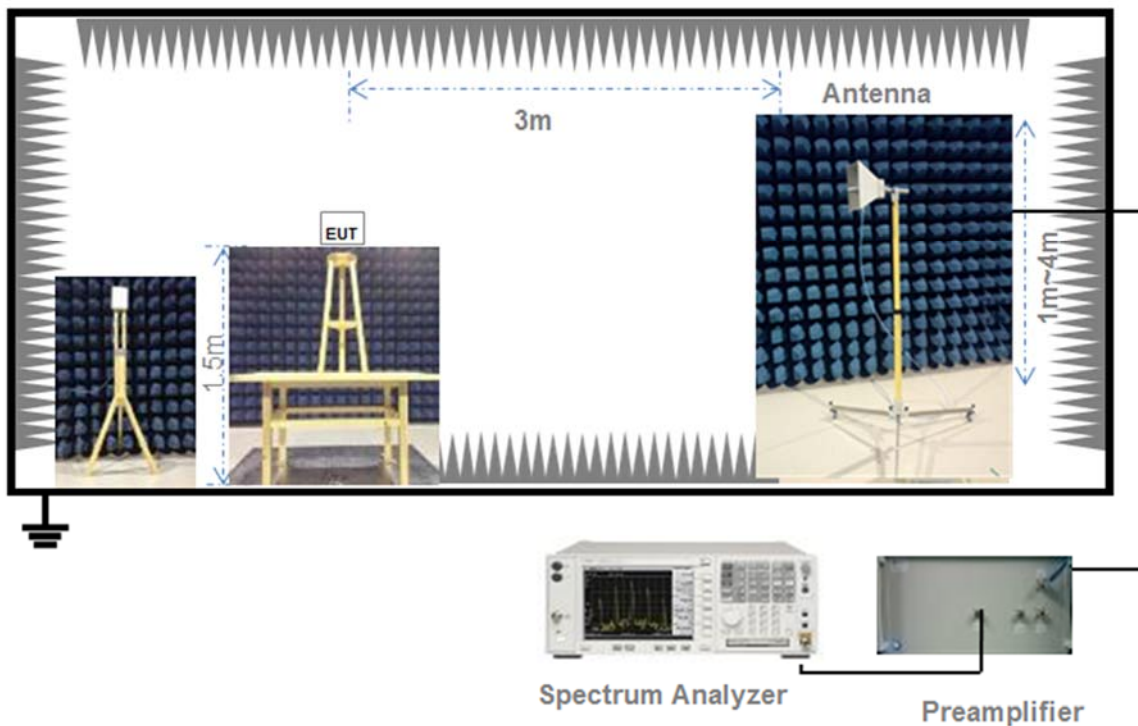
(Diagram 3)

4.4.4 For Radiated Test (30 MHz-1 GHz)



(Diagram 4)

4.4.5 For Radiated Test (Above 1 GHz)



(Diagram 5)

4.5 Measurement Results Explanation Example

4.5.1 For conducted test items:

The offset level is set in the spectrum analyzer to compensate the RF cable loss and attenuator between EUT conducted output port and spectrum analyzer. With the offset compensation, the spectrum analyzer reading level is exactly the EUT RF output level.

The spectrum analyzer offset is derived from RF cable loss and attenuator factor.

Offset = RF cable loss + attenuator factor.

4.5.2 For radiated band edges and spurious emission test:

Per part 15.35(c), the EUT Bluetooth average emission level could be determined by the peak emission level applying duty cycle correction factor, to represent averaging over the whole pulse train.

The average level is derived from the peak level corrected with "Duty cycle correction factor".

Average Emission Level (dBuV/m) = Peak Emission Level (dBuV/m) + Duty cycle correction factor (dB)

Duty cycle correction factor (dB) = $20 * \log (\text{Duty cycle})$.

Duty cycle = on time / 100 milliseconds

On time = dwell time * hopping number in 100 ms

For example: bluetooth with dwell time 2.9 ms and 3 hops in 100 ms, then

Duty cycle correction factor (dB) = $20 * \log ((2.9 * 3) / 100) = -21.21 \text{ dB}$

Following shows an average computation example with duty cycle correction factor = -21.21 dB, and the peak emission level is 45.61 dBuV/m.

Example:

Average Emission Level (dBuV/m) = Peak Emission Level (dBuV/m) + duty cycle correction factor (dB)

= $45.61 + (-21.21) = 24.4 \text{ (dBuV/m)}$

5 TEST ITEMS

5.1 Antenna Requirements

5.1.1 Standard Applicable

FCC §15.203 & 15.247(b); RSS-247, 5.4 (6)

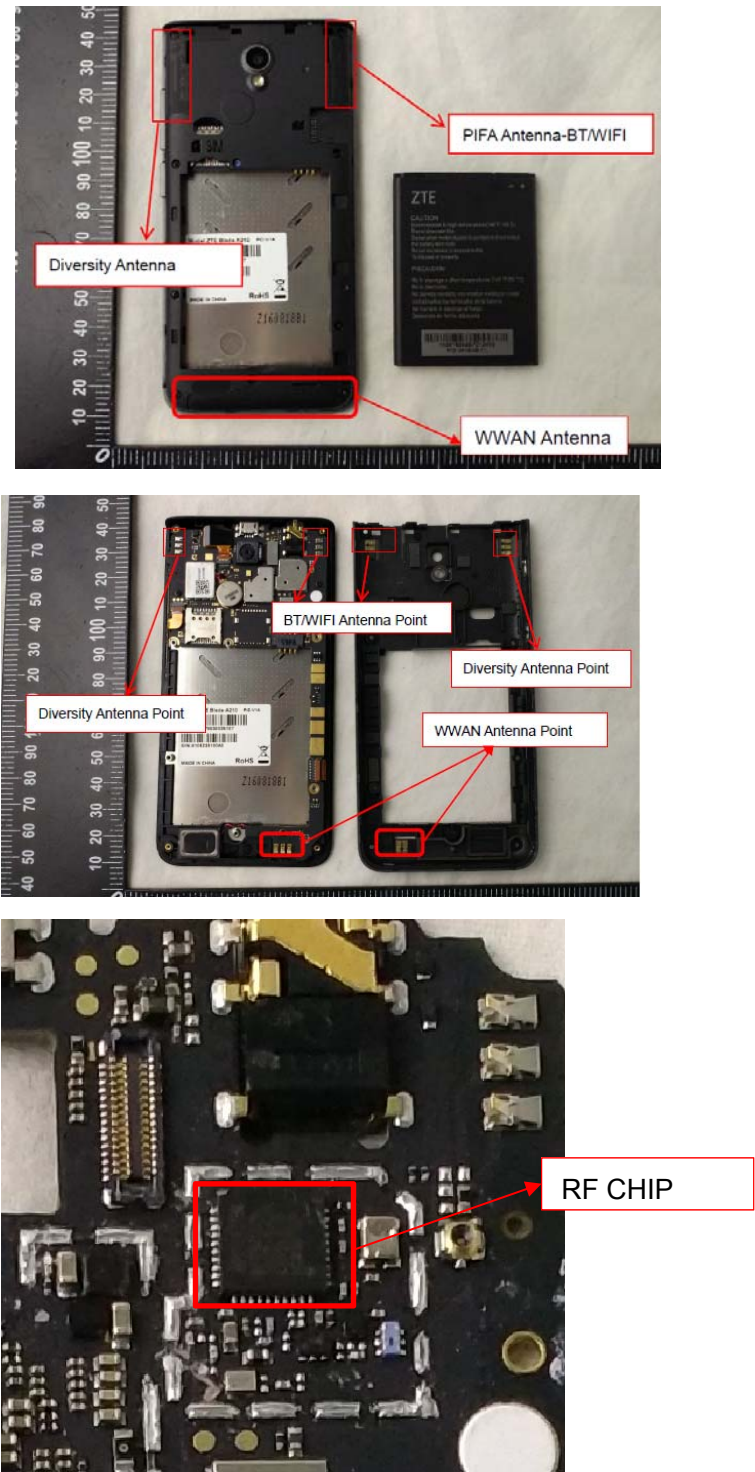
An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. This requirement does not apply to carrier current devices or to devices operated under the provisions of § 15.211, § 15.213, § 15.217, § 15.219, or § 15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter protection systems and some field disturbance sensors, or to other intentional radiators which, in accordance with § 15.31(d), must be measured at the installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this part are not exceeded.

If directional gain of transmitting antennas is greater than 6 dBi, the power shall be reduced by the same level in dB comparing to gain minus 6 dBi. For the fixed point-to-point operation, the power shall be reduced by one dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the FCC rule.

5.1.2 Antenna Anti-Replacement Construction

The Antenna Anti-Replacement as following method:

Protected Method	Description
The antenna is An embedded-in	The antenna is welded on the mainboard, can't be replaced by the consumer

Reference Documents	Item
Photo	 The photographs illustrate the antenna configuration of the ZTE smartphone. The top image shows the back cover with three labeled antenna locations: PIFA Antenna-BT/WIFI (top right), Diversity Antenna (top left), and WWAN Antenna (bottom center). The middle image shows the internal components with three labeled antenna points: BT/WIFI Antenna Point (top center), Diversity Antenna Point (top left), and WWAN Antenna Point (bottom center). The bottom image is a close-up of the RF CHIP on the internal circuit board.

5.1.3 Antenna Gain

The antenna peak gain of EUT is less than 6 dBi. Therefore, it is not necessary to reduce maximum peak output power limit.

5.2 Number of Hopping Frequencies

5.2.1 Limit

FCC §15.247(a) (1) (iii); RSS-247, 5.1 (4)

Frequency hopping systems operating in the 2400 MHz to 2483.5 MHz bands shall use at least 15 hopping frequencies.

5.2.2 Test Setup

See section 4.4.1 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.2.3 Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

Span = the frequency band of operation

RBW $\geq$ 1% of the span

VBW $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

Allow the trace to stabilize

5.2.4 Test Result

Please refer to ANNEX A.1.

5.3 Peak Output Power and E.I.R.P

5.3.1 Test Limit

FCC § 15.247(b)

For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.

RSS-247, 5.4 (2)

For FHSs operating in the band 2400-2483.5 MHz, the maximum peak conducted output power shall not exceed 1.0 W and the e.i.r.p. shall not exceed 4 W if the hopset uses 75 or more hopping channels; the maximum peak conducted output power shall not exceed 0.125 W and the e.i.r.p. shall not exceed 0.5 W if the hopset uses less than 75 hopping channels (see Section 5.4(5) for exceptions).

5.3.2 Test Setup

See section 4.4.1 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.3.3 Test Procedure

The Module operates at hopping-off test mode. The lowest, middle and highest channels are selected to perform testing to verify the conducted RF output peak power of the Module.

Use the following spectrum analyzer settings:

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

RBW > the 20 dB bandwidth of the emission being measured

VBW $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

Allow the trace to stabilize.

5.3.4 Test Result

Please refer to ANNEX A.2.

5.4 Occupied Bandwidth

5.4.1 Limit

FCC §15.247(a); RSS-247, 5.1 (1)

Measurement of the 20dB bandwidth of the modulated signal.

5.4.2 Test Setup

See section 4.4.1 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.4.3 Test Procedure

Use the following spectrum analyzer settings:

Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel

RBW = in the range of 1% to 5% of the OBW

VBW $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

The EUT should be transmitting at its maximum data rate, Allow the trace to stabilize.

5.4.4 Test Result

Please refer to ANNEX A.3.

5.5 Carrier Frequency Separation

5.5.1 Limit

FCC §15.247(a); RSS-247, 5.1 (2)

Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.

5.5.2 Test Setup

See section 4.4.1 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.5.3 Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

Span = wide enough to capture the peaks of two adjacent channels

Resolution (or IF) Bandwidth (RBW) $\geq 1\%$ of the span

Video (or Average) Bandwidth (VBW) $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels.

5.5.4 Test Result

Please refer to ANNEX A.4.

5.6 Time of Occupancy (Dwell time)

5.6.1 Limit

FCC §15.247(a); RSS-247, 5.1 (4)

Frequency hopping systems in the 2400 MHz - 2483.5 MHz band shall use at least 15 non-overlapping channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

5.6.2 Test Setup

See section 4.4.1 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.6.3 Test Procedure

The average time of occupancy on any channel within the Period can be calculated with formulas:

For DH1 package type

$$\{\text{Total of Dwell}\} = \{\text{Pulse Time}\} * (1600 / 2) / \{\text{Number of Hopping Frequency}\} * \{\text{Period}\}$$

$$\{\text{Period}\} = 0.4 \text{ s} * \{\text{Number of Hopping Frequency}\}$$

For DH3 package type

$$\{\text{Total of Dwell}\} = \{\text{Pulse Time}\} * (1600 / 4) / \{\text{Number of Hopping Frequency}\} * \{\text{Period}\}$$

$$\{\text{Period}\} = 0.4 \text{ s} * \{\text{Number of Hopping Frequency}\}$$

For DH5 package type

$$\{\text{Total of Dwell}\} = \{\text{Pulse Time}\} * (1600 / 6) / \{\text{Number of Hopping Frequency}\} * \{\text{Period}\}$$

$$\{\text{Period}\} = 0.4 \text{ s} * \{\text{Number of Hopping Frequency}\}$$

The lowest, middle and highest channels are selected to perform testing to record the dwell time of each occupation measured in this channel, which is called Pulse Time here.

5.6.4 Test Result

Please refer to ANNEX A.5

5.7 Conducted Spurious Emission & Authorized-band band-edge

5.7.1 Limit

FCC §15.247(d); RSS-247, 5.5

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.

5.7.2 Test Setup

See section 4.4.1 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.7.3 Test Procedure

Use the following spectrum analyzer settings:

Span = wide enough to capture the peak level of the in-band emission and all spurious emissions (e.g., harmonics) from the lowest frequency generated in the EUT up through the 10th harmonic. Typically, several plots are required to cover this entire span.

RBW = 100 kHz

VBW $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

Allow the trace to stabilize

5.7.4 Test Result

Please refer to ANNEX A.6.

5.8 Conducted Emission

5.8.1 Limit

FCC §15.207; RSS-GEN, 8.8

For an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150 kHz to 30 MHz shall not exceed the limits in the following table, as measured using a 50 μ H/50 Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dB μ V)	
	Quai-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
0.50 - 30	60	50

5.8.2 Test Setup

See section 4.4.2 for test setup description for the AC power supply port. The photo of test setup please refer to ANNEX B.

5.8.3 Test Procedure

The maximum conducted interference is searched using Peak (PK), if the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. Refer to recorded points and plots below.

Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

5.8.4 Test Result

Please refer to ANNEX A.7.

5.9 Radiated Spurious Emission

5.9.1 Limit

FCC §15.209&15.247(d); RSS-247, 5.5

Radiated emission outside the frequency band attenuation below the general limits specified in FCC section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in FCC section 15.205(a), must also comply with the radiated emission limits specified in FCC section 15.209(a).

According to FCC section 15.209 (a), except as provided elsewhere in this subpart, the emissions from an intentional radiator shall not exceed the field strength levels specified in the following table:

Frequency (MHz)	Field Strength ($\mu\text{V/m}$)	Measurement Distance (m)
0.009 - 0.490	$2400/F(\text{kHz})$	300
0.490 - 1.705	$24000/F(\text{kHz})$	30
1.705 - 30.0	30	30
30 - 88	100	3
88 - 216	150	3
216 - 960	200	3
Above 960	500	3

Note:

1. Field Strength ($\text{dB}\mu\text{V/m}$) = $20 \cdot \log[\text{Field Strength } (\mu\text{V/m})]$.
2. In the emission tables above, the tighter limit applies at the band edges.
3. For Above 1000 MHz, the emission limit in this paragraph is based on measurement instrumentation employing an average detector, measurement using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit.
4. For above 1000 MHz, limit field strength of harmonics: $54\text{dB}\mu\text{V/m}@3\text{m}$ (AV) and $74\text{dB}\mu\text{V/m}@3\text{m}$ (PK).

5.9.2 Test Setup

See section 4.4.3 to 4.4.5 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.9.3 Test Procedure

The measurement frequency range is from 9 kHz to the 10th harmonic of the fundamental frequency. The Turn Table is actuated to turn from 0° to 360° , and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

The power of the EUT transmitting frequency should be ignored.

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1$ GHz, 100 kHz for $f < 1$ GHz

VBW $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

For measurement below 1GHz, If the emission level of the EUT measured by the peak detector is 3 dB lower than the applicable limit, the peak emission level will be reported, Otherwise, the emission measurement will be repeated using the quasi-peak detector and reported.

5.9.4 Test Result

Please refer to ANNEX A.8.

5.10 Band Edge (Restricted-band band-edge)

5.10.1 Limit

FCC §15.209&15.247(d)

Radiated emission outside the frequency band attenuation below the general limits specified in FCC section 15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in FCC section 15.205(a), must also comply with the radiated emission limits specified in FCC section 15.209(a).

5.10.2 Test Setup

See section 4.4.3 to 4.4.5 for test setup description for the antenna port. The photo of test setup please refer to ANNEX B.

5.10.3 Test Procedure

The measurement frequency range is from 9 kHz to the 10th harmonic of the fundamental frequency. The Turn Table is actuated to turn from 0° to 360°, and both horizontal and vertical polarizations of the Test Antenna are used to find the maximum radiated power. Mid channels on all channel bandwidth verified. Only the worst RB size/offset presented.

The power of the EUT transmitting frequency should be ignored.

All Spurious Emission tests were performed in X, Y, Z axis direction. And only the worst axis test condition was recorded in this test report.

Use the following spectrum analyzer settings:

Span = wide enough to fully capture the emission being measured

RBW = 1 MHz for $f \geq 1$ GHz, 100 kHz for $f < 1$ GHz

VBW $\geq$ RBW

Sweep = auto

Detector function = peak

Trace = max hold

For measurement below 1GHz, If the emission level of the EUT measured by the peak detector is 3 dB lower than the applicable limit, the peak emission level will be reported, Otherwise, the emission measurement will be repeated using the quasi-peak detector and reported.

5.10.4 Test Result

Please refer to ANNEX A.9.

ANNEX A TEST RESULT

A.1 Number of Hopping Frequency

The Number of Hopping Frequency result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.1 Number of Hopping Frequency.

A.2 Peak Output Power and E.I.R.P

The Peak Output Power and E.I.R.P result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.2 Peak Output Power.

A.3 20 dB and 99% bandwidth

The 20 dB and 99% bandwidth result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.3 20 dB and 99% bandwidth.

A.4 Hopping Frequency Separation

The Hopping Frequency Separation result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.4 Hopping Frequency Separation.

A.5 Average Time of Occupancy

The Average Time of Occupancy result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.5 Average Time of Occupancy.

A.6 Conducted Spurious Emissions & Authorized-band band-edge

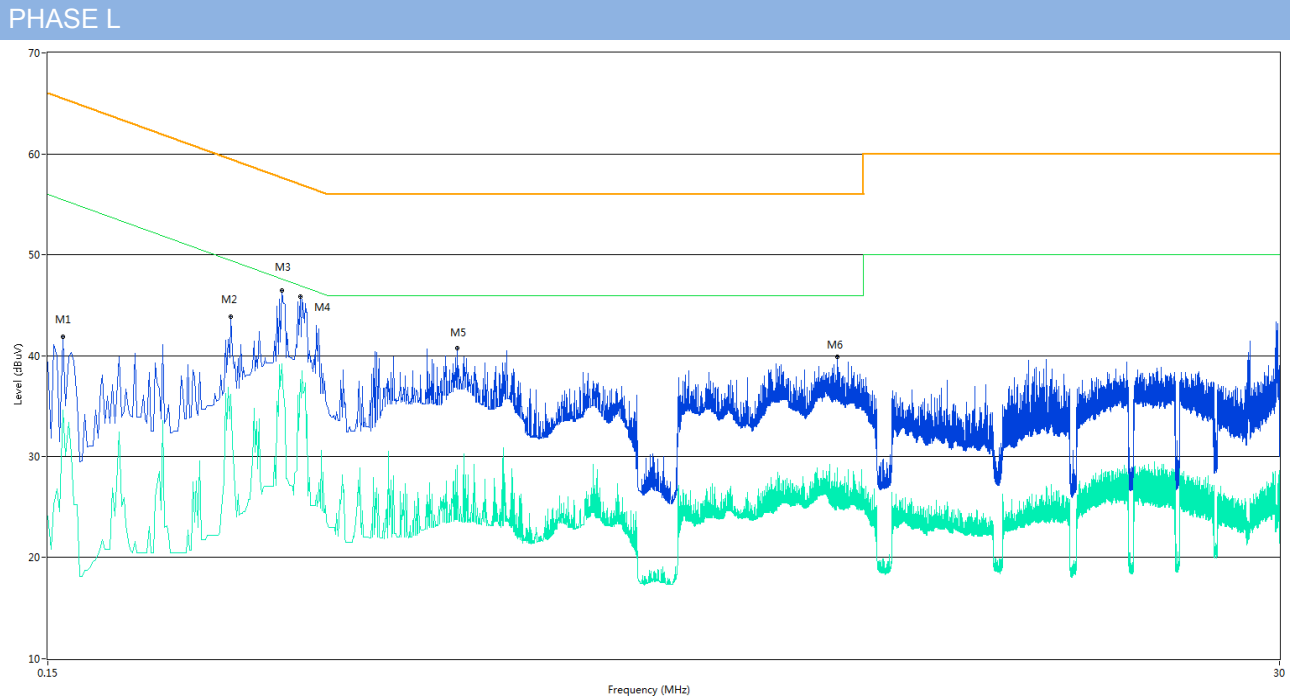
The Conducted Spurious Emissions & Authorized-band band-edge result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.6 Conducted Spurious Emissions & Authorized-band band-edge.

A.7 Conducted Emissions

Note 1: The EUT is working in the Normal link mode.

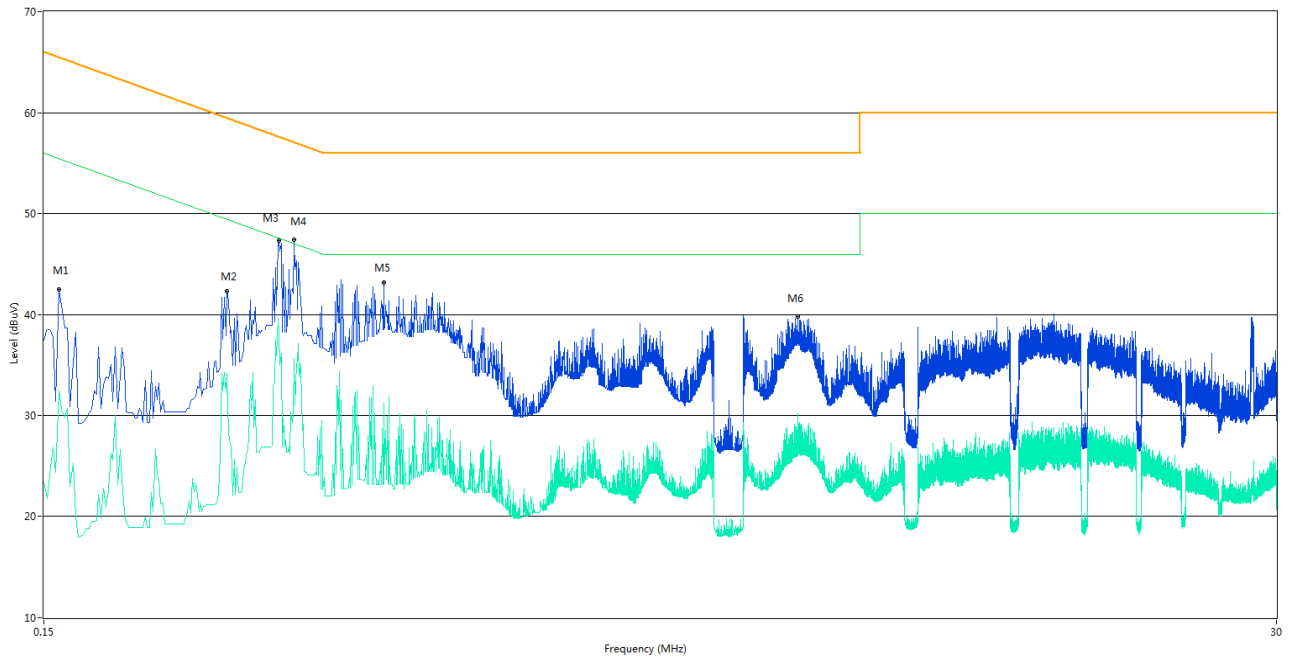
Note 2: Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a nominal 120 VAC, 60 Hz and 240 VAC, 50 Hz) for which the device is capable of operation. So, The configuration 120 VAC, 60 Hz and 240 VAC, 50 Hz were tested respectively, but only the worst configuration (120 VAC, 60 Hz) shown here.

Test Data and Plots



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.160	41.9	10.29	65.5	23.60	Peak	L Line	Pass
1**	0.160	34.5	10.29	55.5	21.00	AV	L Line	Pass
2	0.330	43.9	11.05	59.5	15.60	Peak	L Line	Pass
2**	0.330	36.1	11.05	49.5	13.40	AV	L Line	Pass
3	0.410	46.5	10.36	57.6	11.10	Peak	L Line	Pass
3**	0.410	39.2	10.36	47.6	8.40	AV	L Line	Pass
4	0.444	45.8	10.51	57.0	11.20	Peak	L Line	Pass
4**	0.444	37.6	10.51	47.0	9.40	AV	L Line	Pass
5	0.872	40.7	9.78	56.0	15.30	Peak	L Line	Pass
5**	0.872	29.1	9.78	46.0	16.90	AV	L Line	Pass
6	4.476	40.0	10.26	56.0	16.00	Peak	L Line	Pass
6**	4.476	28.9	10.26	46.0	17.10	AV	L Line	Pass

PHASE N



No.	Frequency (MHz)	Results (dBuV)	Factor (dB)	Limit (dBuV)	Margin (dB)	Detector	Line	Verdict
1	0.160	42.5	10.29	65.5	23.00	Peak	N Line	Pass
1**	0.160	32.4	10.29	55.5	23.10	AV	N Line	Pass
2	0.330	42.4	11.05	59.5	17.10	Peak	N Line	Pass
2**	0.330	34.1	11.05	49.5	15.40	AV	N Line	Pass
3	0.412	47.3	10.07	57.6	10.30	Peak	N Line	Pass
3**	0.412	38.2	10.07	47.6	9.40	AV	N Line	Pass
4	0.440	47.5	10.56	57.1	9.60	Peak	N Line	Pass
4**	0.440	35.6	10.56	47.1	11.50	AV	N Line	Pass
5	0.646	43.2	10.69	56.0	12.80	Peak	N Line	Pass
5**	0.646	31.2	10.69	46.0	14.80	AV	N Line	Pass
6	3.838	39.8	10.34	56.0	16.20	Peak	N Line	Pass
6**	3.838	26.3	10.34	46.0	19.70	AV	N Line	Pass

A.8 Radiated Spurious Emission

Test Data and Plots

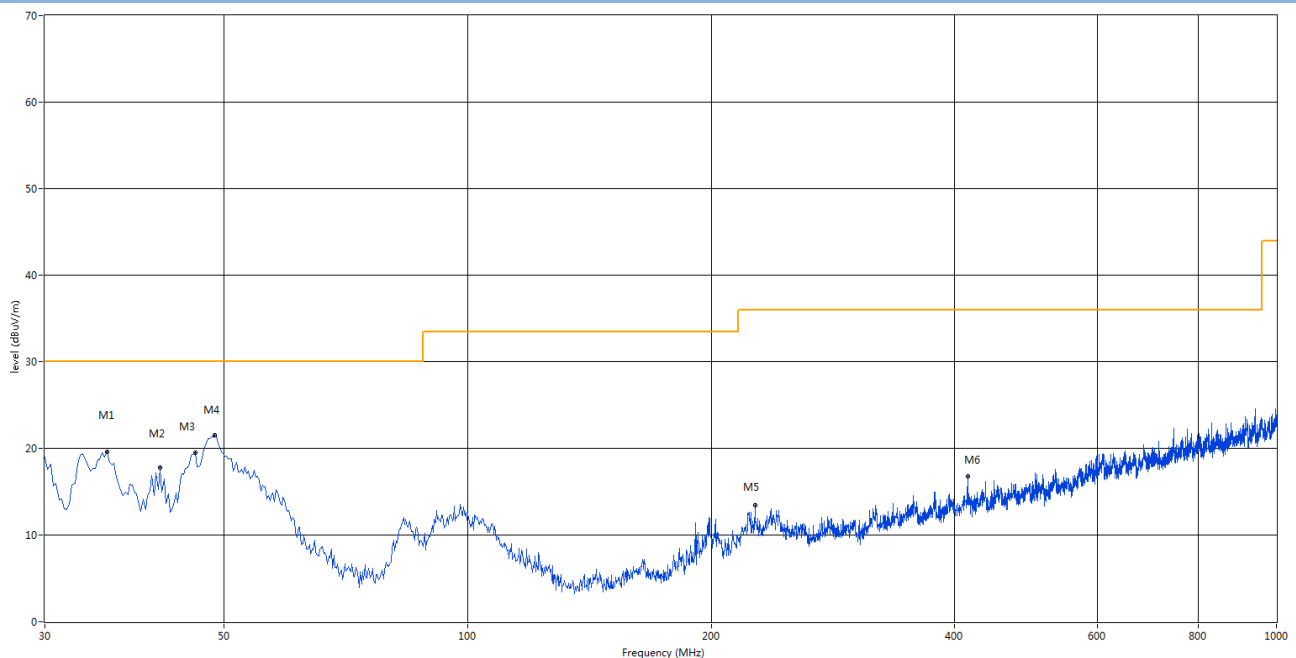
Note¹: The symbol of “--” in the table which means not application.

Note²: For the test data above 1 GHz, according the ANSI C63.10-2013, where limits are specified for both average and peak (or quasi-peak) detector functions, if the peak (or quasi-peak) measured value complies with the average limit, it is unnecessary to perform an average measurement.

Note³: The Radiated Spurious Emission 1 GHz to 25 GHz result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.8 The Radiated Spurious Emission.

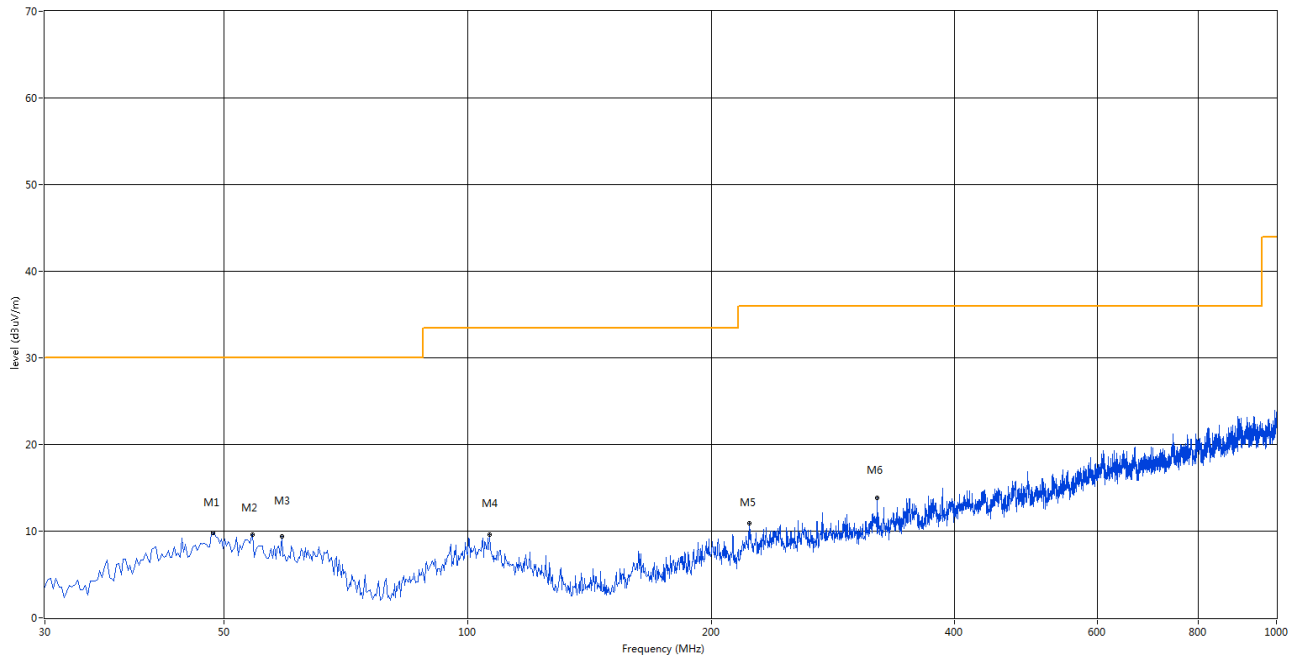
Note⁴: The EUT is working in the Normal link mode below 1 GHz.

30 MHz to 1 GHz, ANT V



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	35.819	19.61	-15.99	30.0	10.39	Peak	102.00	100	Vertical	Pass
2	41.637	17.77	-13.95	30.0	12.23	Peak	48.00	100	Vertical	Pass
3	46.001	19.44	-13.36	30.0	10.56	Peak	360.00	200	Vertical	Pass
4	48.668	21.53	-13.28	30.0	8.47	Peak	360.00	200	Vertical	Pass
5	226.618	13.40	-14.44	36.0	22.60	Peak	109.00	200	Vertical	Pass
6	414.994	16.70	-9.37	36.0	19.30	Peak	360.00	200	Vertical	Pass

30 MHz to 1 GHz, ANT H



No.	Frequency (MHz)	Results (dBuV/m)	Factor (dB)	Limit (dBuV/m)	Margin (dB)	Detector	Table (o)	Height (cm)	ANT	Verdict
1	48.425	9.77	-13.30	30.0	20.23	Peak	0.00	100	Horizontal	Pass
2	54.244	9.59	-13.55	30.0	20.41	Peak	18.00	100	Horizontal	Pass
3	58.850	9.37	-14.80	30.0	20.63	Peak	48.00	100	Horizontal	Pass
4	106.368	9.56	-15.12	33.5	23.94	Peak	132.00	100	Horizontal	Pass
5	223.224	10.88	-14.67	36.0	25.12	Peak	299.00	100	Horizontal	Pass
6	320.685	13.83	-11.77	36.0	22.17	Peak	227.00	100	Horizontal	Pass

A.9 Band Edge (Restricted-band band-edge)

The Band Edge (Restricted-band band-edge) result reference from original test report BL-SZ1650193-602 (issued by Shenzhen BALUN Technology Co., Ltd., on Jun. 12, 2016) A.9 Band Edge (Restricted-band band-edge).

ANNEX B TEST SETUP PHOTOS

Please refer the document “BL-SZ1760126-AR.PDF”.

ANNEX C EUT EXTERNAL PHOTOS

Please refer the document “BL- SZ1760126-AW.PDF”.

ANNEX D EUT INTERNAL PHOTOS

Please refer the document “BL- SZ1760126-AI.PDF”.

--END OF REPORT--